Dual N-Channel PowerTrench® MOSFET

40 V, 7 A, 20 mΩ



This device includes two 40 V N-Channel MOSFETs in a dual Power 33 (3 mm x 3 mm MLP) package. The package is enhanced for exceptional thermal performance.

Features

- Max $r_{DS(on)} = 20 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 7 \text{ A}$
- Max $r_{DS(on)} = 27 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 6 \text{ A}$
- Low Inductance Packaging Shortens Rise/Fall Times
- Lower Switching Losses
- 100% Rg Tested
- This Device is Pb-Free and is RoHS Compliant

Applications

- Battery Protection
- Load Switching
- Point of Load

MOSFET MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)

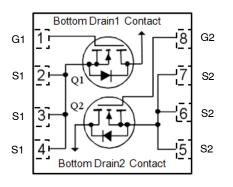
Symbol	Parameter	Ratings	Units	
VDS	Drain to Source Voltage	40	V	
Vgs	Gate to Source Voltage	±20	V	
I_D	Drain Current		20	Α
	- Continuous $T_C = 25^{\circ}C$ - Continuous $T_A = 25^{\circ}C$	(Note 1a)	7	
	- Pulsed	(Note 4)	50	
Eas	Single Pulse Avalanche Energy (Note 3)		13	mJ
P_{D}	Power Dissipation T _C = 25°C		12	W
. 0	Power Dissipation T _A = 25°C	(Note 1a)	1.9	
Тл, Тѕтс	Operating and Storage Junction Te Range	-55 to +150	°C	

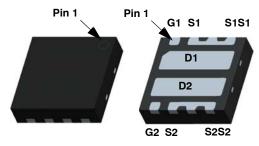
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



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Power 33

WDFN8 3x3, 0.65P CASE 511DG

MARKING DIAGRAM

o \$Y&Z&2&K FDMC 8032L

\$Y = ON Semiconductor Logo &Z = Assembly Plant Code &2 = Numeric Date Code

&K = Lot Code

FDMC8032L = Specific Device Code

ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

THERMAL CHARACTERISTICS

Rating	Symbol	Value	Unit
$R_{ heta JC}$	Thermal Resistance, Junction to Case	9.7	°C/W
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	65	

PACKAGE MARKING AND ORDERING INFORMATION

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMC8032L	FDMC8032L	Power 33	13"	12 mm	3000 Units

ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise noted)

Parameter	Test Conditions	Symbol	Min.	Тур.	Max.	Unit
OFF CHARA	ACTERISTICS				•	
BVDSS	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	40			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25°C		23		mV/°C
IDSS	Zero Gate Voltage Drain Current	V _{DS} = 32 V, V _{GS} = 0 V			1	μΑ
IGSS	Gate to Source Leakage Current, Forward	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
ON CHARAC	CTERISTICS					
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	1.0	1.8	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25°C		-5		mV/°C
r _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 7 A		16	20	mΩ
		V _{GS} = 4.5 V, I _D = 6 A		21	27	
		V _{GS} = 10 V, I _D = 7 A, T _J = 125°C		23	29	
9 _{FS}	Forward Transconductance	V _{DD} = 5 V, I _D = 7 A		27		S
OYNAMIC C	HARACTERISTICS					
C _{iss}	Input Capacitance	V _{DS} = 20 V, V _{GS} = 0 V f = 1 MHz		513	720	pF
C _{oss}	Output Capacitance	T = 1 MHZ		137	195	pF
C_{rss}	Reverse Transfer Capacitance			9.3	15	pF
R_g	Gate Resistance		0.1	2.6	3.6	Ω
SWITCHING	CHARACTERISTICS					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 20 \text{ V}, I_D = 7 \text{ A}$ $V_{GS} = 10 \text{ V},$		5.5	11	ns
t _r	Rise Time	$R_{GEN} = 6 \Omega$		1.2	10	ns
t _{d(off)}	Turn-Off Delay Time]		13	24	ns
t _f	Fall Time]		1.3	10	ns
Q _{g(TOT)}	Total Gate Charge	V _{GS} = 0 V to 10 V		7.6	11	nC
	Total Gate Charge	V _{GS} = 0 V to 4.5 V		3.6	5.1	nC
Q _{gs}	Gate to Source Charge	V _{DD} = 20 V		1.5		nC
Q _{gd}	Gate to Drain "Miller" Charge	$I_D = 7 A$		1.0		nC

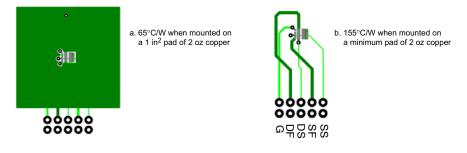
ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise noted) (continued)

Parameter	Test Conditions	Symbol	Min.	Тур.	Max.	Unit
DRAIN-SOURCE DIODE CHARACTERISTICS						
V _{SD}	Source to Drain Diode Forward Voltage	V _{GS} = 0 V, I _S = 7 A (Note 2)		0.85	1.3	V
		V _{GS} = 0 V, I _S = 1.4 A (Note 2)		0.75	1.2	
t _{rr}	Reverse Recovery Time	I _F = 7 A, di/dt = 100 A/μs		16	29	ns
Q _{rr}	Reverse Recovery Charge			3.9	10	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

NOTES:

1. $R_{\theta JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



- 2. Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%.
- 3. E_{AS} of 13 mJ is based on starting T_J = 25°C, L = 3 mH, I_{AS} = 3 A, V_{DD} = 40 V, V_{GS} = 10 V. 100% tested at L = 0.1 mH, I_{AS} = 11 A. 4. Pulse Id refers to Figure.11 Forward Bias Safe Operation Area.

TYPICAL CHARACTERISTICS

DRAIN TO SOURCE ON-RESISTANCE

NORMALIZED

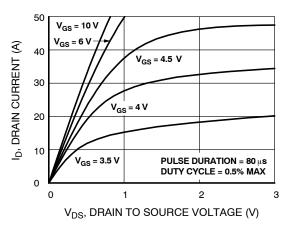


Figure 1. On-Region Characteristics

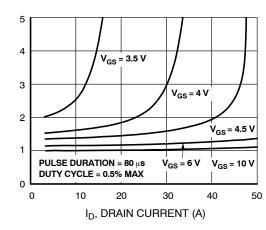


Figure 2. Normalized On–Resistance vs Drain Current and Gate Voltage

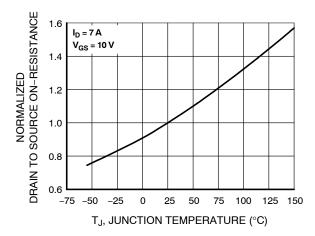


Figure 3. Normalized On-Resistance vs Junction Temperature

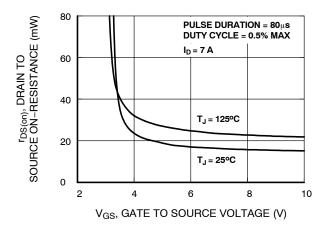


Figure 4. On-Resistance vs Gate to Source Voltage

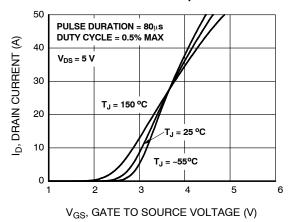


Figure 5. Transfer Characteristics

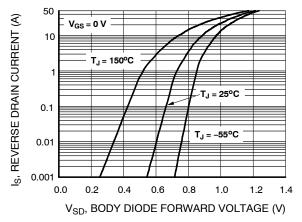


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

TYPICAL CHARACTERISTICS (continued)

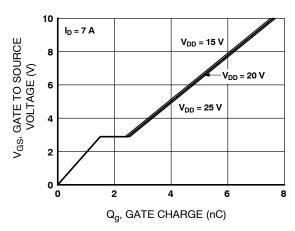


Figure 7. Gate Charge Characteristics

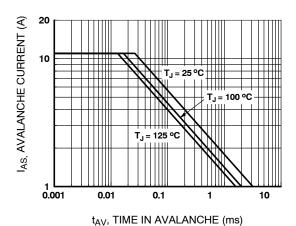


Figure 9. Unclamped Inductive Switching Capability

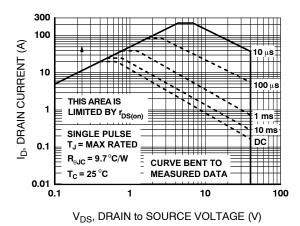
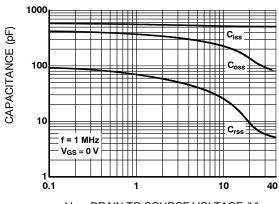
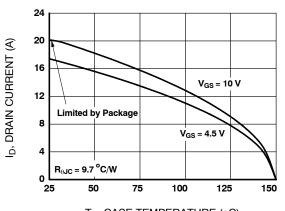


Figure 11. Forward Bias Safe Operating Area



V_{DS}, DRAIN TO SOURCE VOLTAGE (V)

Figure 8. Capacitance vs Drain to Source Voltage



T_C, CASE TEMPERATURE (oC)

Figure 10. Maximum Continuous Drain Current vs Case Temperature

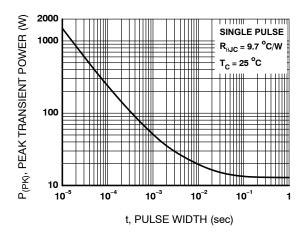


Figure 12. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS (continued)

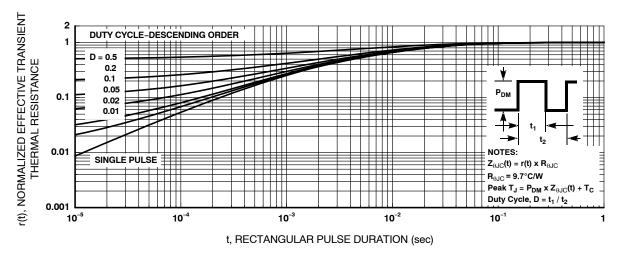
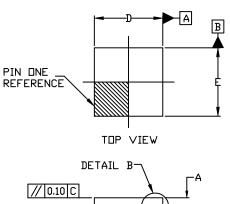
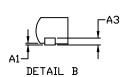


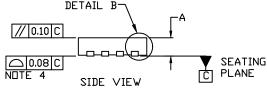
Figure 13. Transient Thermal Response Curve

WDFN8 3x3, 0.65P CASE 511DG **ISSUE A**

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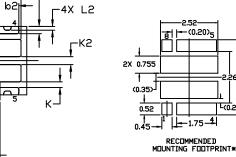




-D2 2X

5X E5

8X b ⊕ 0.10 C A B 0.05 C



Information on our Pb-Free strategy and alls, please download the DN Semiconductor Mounting Techniques Reference Manual,

<u>__(0</u>,50)5X

NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- CONTROLLING DIMENSION: MILLIMETERS
- DIMENSION 6 APPLIES TO PLATED TERMINALS AND IS MEASURED BETWEEN 0.15 AND 0.30MM FROM THE TERMINAL TIP.
- 4. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

	MILLIMETERS			
DIM	MIN.	N□M.	MAX.	
Α	0.70	0.75	0.80	
A1	0.00		0.05	
A3	ĺ	0.20 REF	•	
Ø	0.30	0.35	0.40	
b2	1.65 REF			
D	2.90	3.00	3.10	
D2	2.45	2.50	2.55	
E	2.90	3.00	3.10	
E2	1.40	1.50	1.60	
٩		0.65 BSC	,	
Κ	0.25			
К2	0.35 REF			
L	0.27	0.32	0.37	
L2	0.163 REF			

GENERIC MARKING DIAGRAM*

BOTTOM VIEW



XXXX = Specific Device Code = Assembly Location

= Year WW = Work Week = Pb-Free Package

(Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

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